

**Search Notes**

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Examiner

Pierre-Louis Desir

Applicant(s)/Patent under  
Reexamination

CHUN, CHANG-HYEN

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
455	442	9/13/2006	PD
455	436	9/13/2006	PD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/13/2006	PD